

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination SAKSUN, JOHN
	Examiner EDMUND H LEE	Art Unit 1732

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-4988104	01-1991	Shiotani et al	273/167
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
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J	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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